

UTC UNISONIC TECHNOLOGIES CO., LTD

7N70-M

Preliminary

Power MOSFET

7A, 700V N-CHANNEL POWER MOSFET

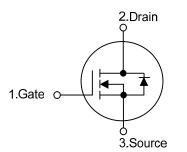
DESCRIPTION

The UTC 7N70-M is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

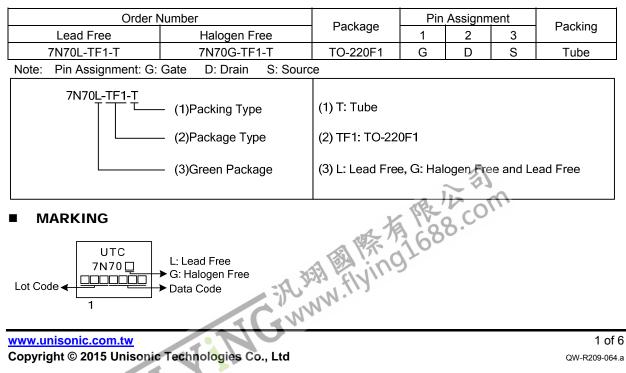
FEATURES

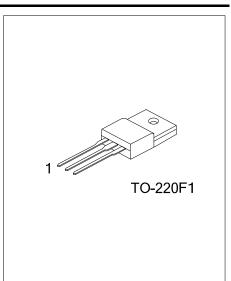
- * $R_{DS(ON)}$ < 1.4 Ω @ V_{GS} = 10V, I_D = 3.5A
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

SYMBOL



ORDERING INFORMATION





■ ABSOLUTE MAXIMUM RATINGS (T_c = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V _{DSS}	700	V	
Gate-Source Voltage		V _{GSS}	±30	V	
Continuous Drain Current	T _C = 25°C	- I _D	7.0	А	
	T _C = 100°C		4.7	А	
Drain Current Pulsed (Note 2)		I _{DM}	28	А	
Avalanche Energy, Single Pulsed (Note 3)		E _{AS}	380	mJ	
Avalanche Energy, Repetitive, Limited by T _{JMAX}		E _{AR}	14.2	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation ($T_c = 25^{\circ}C$)		PD	48	W	
Junction Temperature		ТJ	+150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by T_J

3. L=15.5mH, I_{AS} =7.0A, V_{DD} =50V, R_G =0 Ω , Starting T_J =25°C

4. I_{SD} ≤ 7.0A, di/dt ≤100A/µs, V_{DD} ≤ BV_{DSS}, Starting T_J=25°C

THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ _{JA}	62.5	°C/W	
Junction to Case	θις	2.6	°C/W	



■ ELECTRICAL CHARACTERISTICS (T_c =25°C, unless otherwise specified)

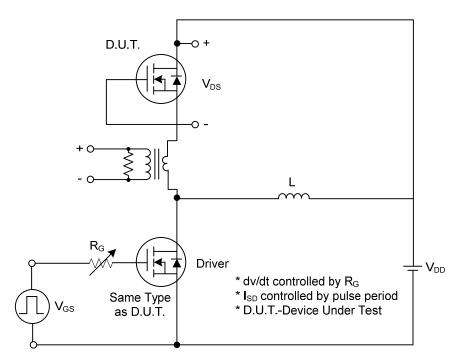
		1	1	1	r	r	
PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	V _{GS} = 0V, I _D = 250μA	700			V
Drain-Source Leakage Current		I _{DSS}	$V_{DS} = 700V, V_{GS} = 0V$			1	μA
			V _{DS} = 560V, T _C = 125°C			1	μA
Gate-Source Leakage Current	Forward	– I _{GSS}	$V_{GS} = 30V, V_{DS} = 0V$			100	nA
	Reverse		V_{GS} = -30V, V_{DS} = 0V			-100	nA
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS} / \triangle T_J$	I _D = 250mA		0.67		V/°C
			Referenced to 25°C		0.07		v/ C
ON CHARACTERISTICS							
Gate Threshold Voltage		V _{GS(TH)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V
Drain-Source ON-State Resistance		R _{DS(ON)}	V _{GS} = 10V, I _D = 3.5A			1.4	Ω
DYNAMIC CHARACTERISTICS							
Input Capacitance		C _{ISS}	V _{DS} = 25V, V _{GS} = 0V, f = 1MHz		1000		pF
Output Capacitance		C _{OSS}			97		pF
Reverse Transfer Capacitance		C _{RSS}			19		pF
SWITCHING CHARACTERISTIC	S						
Total Gate Charge		Q_{G}	V _{DS} = 50V, I _D = 1.3A,		120		nC
Gate-Source Charge		Q_{GS}	V _{GS} = 10V, I _G = 100µA		7		nC
Gate-Drain Charge		Q _{DD}	(Note 1, 2)		18		nC
Turn-on Delay Time		t _{D(ON)}			50		ns
Turn-on Rise Time		t _R	V _{DD} = 30V, V _{GS} = 10V, I _D = 0.5A, R _G =25Ω (Note 1, 2)		80		ns
Turn-off Delay Time		t _{D(OFF)}			295		ns
Turn-off Fall Time		t⊨	(Note 1, 2)		75		ns
SOURCE- DRAIN DIODE RATIN	GS AND CH	ARACTERIS	FICS				
Drain-Source Diode Forward Voltage		V _{SD}	V _{GS} = 0V, I _S =7.0A			1.4	V
Maximum Continuous Drain-Source Diode		I _S				7.0	^
Forward Current						7.0	A
Maximum Pulsed Drain-Source Diode						28	А
Forward Current		I _{SM}				20	А
Reverse Recovery Time		t _{rr}	V _{GS} = 0V, I _S = 7.0A,		320		ns
Reverse Recovery Charge		Q _{RR}	dI _F /dt = 100 A/µs (Note 1)		2.4		μC

Notes: 1. Pulse Test: Pulse width \leq 300µs, Duty cycle \leq 2%

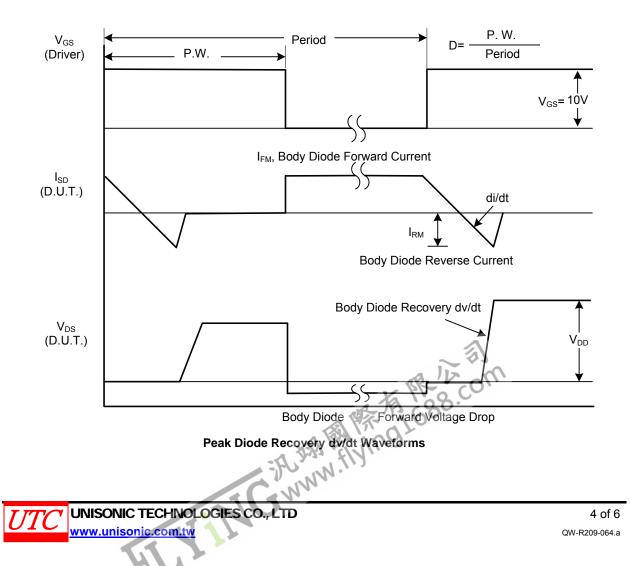
2. Essentially independent of operating temperature

UNISONIC TECHNOLOGIES CO., CTD

TEST CIRCUITS AND WAVEFORMS



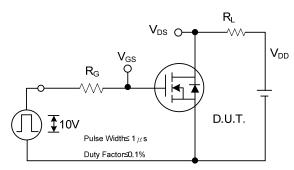
Peak Diode Recovery dv/dt Test Circuit



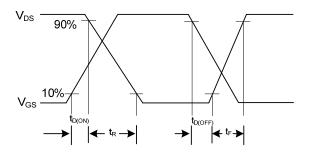
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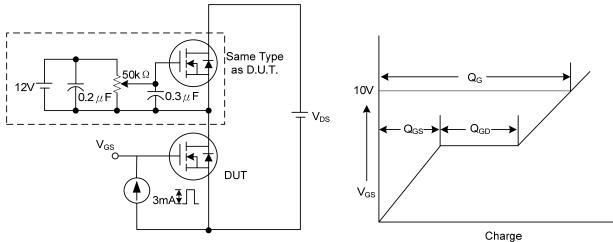
TEST CIRCUITS AND WAVEFORMS (Cont.)



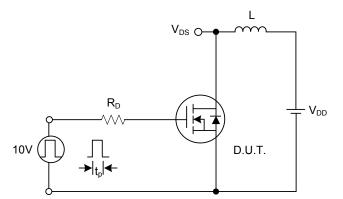




Switching Waveforms

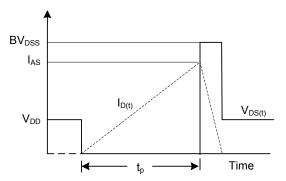


Gate Charge Test Circuit



Unclamped Inductive Switching Test Circuit

Gate Charge Waveform



-REALER PARTIES IN THE COM Unclamped Inductive Switching Waveforms

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